Anisotropic Magnetoresistance of a Classical Antidot Array

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A periodic array of cylindrical voids, embedded in a thin film of n-doped GaAs, displays a pronounced anisotropy of the classical magnetoresistance. For a geometry where the magnetic field lies in the plane of the film, we observe a characteristic dependence on the angle between current and magnetic field. This experimental finding provides a first verification of a recently predicted effect and agrees well with theoretical calculations. The observed anisotropy is due to interactions among current distortions by neighboring voids. [S0031-9007(96)00586-8]

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The magnetoresistance in simple metals has been one of the fundamental problems of transport for decades [1]. Much work was devoted to the role of inhomogeneities by investigating, e.g., intentional thickness variations of aluminum bars [2] or voids in indium wires [3] as model inhomogeneities. Related transport studies in semiconductor materials with periodically varying donor concentration [4] or InSb with a random distribution of needle shaped NiSb inclusions [5] revealed angle dependent magnetoresistance properties. This is in contrast to the resistance of a free electron gas realized, for example, in the conduction band of Fermi degenerate n-doped GaAs, in which a nonquantizing magnetic field \( \mathbf{B} \) shows essentially no dependence on \( \mathbf{B} \). A nonvanishing magnetoresistance will occur when inhomogeneities, such as insulating inclusions, distort the current flow pattern as the current is “rerouted” around the obstacles. Hence, the local current density \( \mathbf{J}(r) \) deviates from its mean value \( \langle \mathbf{J} \rangle = V^{-1} \int_{V} \mathbf{J}(r) \, dV \), taken over the sample volume \( V \). Therefore, the presence of insulating inclusions always increases the total dissipation rate \( \int \mathbf{J} \cdot \mathbf{E} \, dV \) (with \( \mathbf{E} \) the local electric field), and consequently also the effective resistance, above the corresponding values for the homogeneous system [6]. In general, the distortions of the current density become stronger with increasing \( \mathbf{B} \), which results in a positive magnetoresistance [7,8].

Here we address the question how mutual (classical) interactions of current distortions from different inclusions affect the magnetoresistance. For the case of periodically arranged inclusions, such as spheres or cylinders embedded in a host material of different conductivity, detailed calculations have been performed [9]. Those have shown that in the classical conduction regime a distinct anisotropy of the resistance exists with respect to the crystallographic axes of the lattice of inclusions [10,11]. In this Letter we provide a first experimental test of the anticipated effects and also present a simple physical picture of this surprising phenomenon.

As host material we chose a 300 nm thick Si-doped GaAs film grown by molecular beam epitaxy on top of an undoped bulk GaAs layer and a semi-insulating GaAs substrate. With respect to the highly conductive n-doped film, the conductivity of the undoped layer is negligible. At \( T = 90 \) K, the temperature of the experiment, the host n-GaAs had a carrier density of \( n_e = 1.6 \times 10^{18} \) cm\(^{-3} \) and a mobility of \( \mu = 2500 \) cm\(^2\)/Vs, corresponding to a mean free path \( l_e \) of only \( \approx 75 \) nm. In order to perform four point magnetoresistance measurements we fabricated a Hall bar mesa, sketched in Fig. 1(b), by means of optical lithography and standard wet etching. A square array of insulating inclusions was then introduced by drilling cylindrical holes through the 300 nm thick epilayer. These holes, with geometric diameters \( 2r \) of 110, 220, and 260 nm, and a period of \( a = 500 \) nm, were created, like antidots, by electron beam lithography and dry-etching techniques [12]. However, in contrast with two-dimensional antidot arrays, here the transport is both three dimensional and diffusive \( (l_e \ll a) \). Ballistic effects, which are characteristic of two-dimensional electron-gas-based antidots, are not expected to appear under these conditions. An electron micrograph of our classical antidot array is displayed in Fig. 1(a).

The samples were mounted into a superconducting magnet system such that the magnetic field was in the plane of the n-GaAs film. The experimental setup for measuring the angular dependence of the resistance is illustrated in Fig. 1(b). In the experiment, the entire Hall bar, and therefore the applied current \( I_x = Wd J_y \) (where \( W \) and \( d \) are width and (effective) film thickness of the sample) is rotated \textit{in situ} by an angle \( \alpha \) with respect to \( \mathbf{B} \). By measuring the voltage drops \( V_x \) and \( V_y \), the resistance components \( R_{xx} = V_x/I_x \) and \( R_{xy} = V_y/I_x \) were evaluated as a function of \( \alpha \). The resistances are related to the resistivities by the usual relations \( R_{xx} = (L/Wd) \rho_{xx} \) and \( R_{xy} = \rho_{xy}/d \), with \( L \) the sample length.
Full angular dependence of $R_{xx}$ as dash-dotted lines (upper trace: four-terminal geometry. (c) $R_{xx}$ for the magnetoresistance measurements. A constant current of 1 $\mu$A is applied in the $x$ direction. The Hall bar is rotated in situ with respect to the in-plane magnetic field, while the resistance tensor components $R_{xx}$ and $R_{xy}$ are measured in four-terminal geometry. (c) $R_{xx}$ versus $|B|$ for an antidot sample with $r = 130$ nm for $\alpha = 0^\circ$ and $\alpha = 90^\circ$ (solid lines). Reference data from the unpatterned device are shown as dash-dotted lines (upper trace: $R_{xx}$; lower trace: $R_{xy}$). Inset: Full angular dependence of $R_{xx}$ and $R_{xy}$ for the antidot sample at fixed $|B| = 12$ T. All data were taken at $T = 90$ K.

Figure 1(c) displays characteristic data taken from an antidot sample and the corresponding unpatterned reference film. As expected, $R_{xy}$ of the reference sample is practically zero, while $R_{xx}$ is finite but independent of $|B|$ and $\alpha$ (to less than 1% at 12 T). By contrast, both $R_{xx}$ and $R_{xy}$ of the antidot device show a striking dependence on $\alpha$ and $|B|$. $R_{xx}$ exhibits a maximum when $(J_y) \perp B$ and a minimum for $(J_y) \parallel B$, while $R_{xy}$ alternates, having local extrema at $\pi/4$ and $3\pi/4$ [see inset of Fig. 1(c)].

On the left hand side of Fig. 2 polar plots summarize the experimental data for three antidot arrays with different hole diameters. The azimuthal scale corresponds to the angle $\alpha$ while the radial quantity is the normalized resistivity change $\delta\rho_{xx}(|B|, \alpha)/\rho_0$, shown for $|B| = 4$, 8, and 12 T, corresponding to $\mu|B| = 1, 2, 3$, respectively. Here, $\rho_0$ is the zero-field resistivity of each antidot sample. For all samples, a positive magnetoresistance can be observed, which depends characteristically on the hole diameter. With decreasing antidot diameter the relative resistance changes become smaller, but more structure appears in the angular dependence. For the smallest holes, with (geometrical) diameter 110 nm, additional local minima appear around 60$^\circ$ and 120$^\circ$. The experimental data are well reproduced by classical calculations, as shown on the right hand side of Fig. 2 and addressed below.

Angular profiles which follow roughly a $\sin^2 \alpha$ law (with $\alpha$ the angle between $(J)$ and $B$), as in Fig. 2(e), have been reported before, e.g., in semiconductor layers with periodically modulated donor density [4] and in NiSb/InSb systems [5]. However, the richer angular structure, as seen in Fig. 2(a), indicates effects that cannot be accounted for by this earlier work. This angular profile for the sample with the smallest holes is reminiscent of what is observed in pure metals with a non-compact Fermi surface, like copper [13]. However, while the latter is a quantum effect connected with the detailed structure of the Fermi surface, the angular dependence in Fig. 2(a) reflects a nonisotropic resistivity tensor whose origin is entirely classical. Ideally, this could be seen in an experiment where, contrary to ours, the direction of $(J)$ is fixed with respect to $B$ while the antidot lattice is rotated.

While this is difficult to implement, it is possible to transform the measured $\rho_{xx}$ and $\rho_{xy}$ values into resistivities $\rho_{\perp}$ [14] and $\rho_{\parallel}$, defined with respect to a counterclockwise rotated $x'y'$-coordinate system [see Fig. 1(b) and the top of Fig. 3], where $(J)$ is fixed either perpendicular or parallel to $B$, respectively. In both the direct experimental and the transformed representations, the antidot lattice is inclined by $\alpha$ with respect to $B$. For a given

\[
\frac{\delta \rho_{xx}(B, \alpha)}{\rho_0}
\]

![FIG. 1.](image1)

![FIG. 2.](image2)
FIG. 3. Polar plots of \( \delta \rho_{\perp}(B)/\rho_0 \) and \( \delta \rho_{\parallel}(B)/\rho_0 \) for three antidot radii at \( |B| = 12 \) T, i.e., \( \mu|B| = 3 \). Experimental points are shown as open circles, theoretical fits as full lines. The lithographic antidot radii are 55 nm (a),(b), 110 nm (c),(d), and 130 nm (e),(f). Fit parameters used in the calculations are the same as for Fig. 2. Top: Sketch of the experimental \( xy \)- (left) and rotated \( x^0y^0 \)-coordinate systems. In experiment, the \( xy \) frame (the Hall bar) is rotated with respect to \( B \) while in the transformed \( x^0y^0 \) system only the antidot lattice is rotated by \( \alpha \). The rotation transformation to obtain \( \alpha \) reads \( T_{\alpha}(\alpha) = \hat{\rho}^\dagger = T(\alpha)\hat{\rho}T^{-1}(\alpha) \) with the transformation matrix elements \( T_{xx} = T_{yy} = \cos\alpha, T_{xy} = -T_{yx} = \sin\alpha \) and the measured resistivity components \( \rho_{xy}(\alpha) = \rho_{yx}(\alpha) \) and \( \rho_{xx}(\alpha) = \rho_{yy}(\alpha) = \rho_{\parallel}(\alpha) = \rho_{\parallel}(\pi/2 - \alpha) \). We thus obtain the diagonal elements \( \rho_{\parallel} \equiv \rho_{\parallel}^{\parallel} \) and \( \rho_{\perp} \equiv \rho_{\perp}^{\parallel} \). The normalized resistivities \( \delta \rho_{\perp}/\rho_0 \) and \( \delta \rho_{\parallel}/\rho_0 \), displayed in Figs. 3(a)–3(f), exhibit a characteristic cross (\( \delta \rho_{\perp} \)) or cloverleaf (\( \delta \rho_{\parallel} \)) shape with respect to the lattice axes. Again, the sample with the smallest holes [Figs. 3(a) and 3(b)] shows additional angular structure. Note that, even for the sample with the largest hole diameter [Figs. 3(e) and 3(f)], the anisotropy is clearly manifested in this representation, in contrast with a random distribution of voids, where both \( \rho_{\perp} \) and \( \rho_{\parallel} \) would be entirely isotropic.

The experimental data in Figs. 3 and 2 are in striking agreement with calculated traces, which result from a classical calculation based upon the current continuity equation \( \nabla \cdot \left[ \hat{\sigma}(\mathbf{r}) \nabla \phi(\mathbf{r}) \right] = 0 \) for the local electric potential \( \phi(\mathbf{r}) \), using the local free-electron conductivity tensor \( \hat{\sigma} \). The detailed technique which was developed for performing that calculation is described elsewhere [9–11].

In order to compare our data with calculations we have to take into account depletion regions at free surfaces and at the doped or undoped GaAs interface, which increase the hole diameters and reduce the film thickness. We estimate a depletion length of \( l_d = 25 \) nm around the holes and an effective GaAs film thickness of \( d = 240 \) nm. To obtain best agreement with experiment we had to use effective radii which, for the larger holes [plots in Figs. 2(c)–2(f) and 3(c)–3(f)], exceed by typically 35% the sum of...
lithographic radius and $l_d$. This could be due to the gradual change of the carrier density between the holes in contrast to the hard wall inclusions used in the model.

Some aspects of the detailed calculations can be presented in a simple picture illustrating how interaction between current distortions generated by neighboring obstacles leads to the anisotropy. First consider the distortion of a current flow (in the $x$ direction) caused by an isolated obstacle, e.g., the blue cylinder in Fig. 4(a). The distortion is essentially limited to a slab-shaped volume of length proportional to $\mu_0|B|$ in the direction of $\pm B$ [8] (“geometrical shadow” of the cylinder). The “bumps” in the current flow pattern, which have pronounced components also along the $\pm z$ directions, lead to enhanced dissipation proportional to $|B|$ if $\mu_0|B| \gg 1$. Interaction effects arise when the flow patterns of two adjacent inclusions start to overlap. A significant anisotropy of the resistance was predicted to appear for $\mu_0|B| > 1$ [10,11].

The interaction can be analyzed qualitatively by considering the superposition of distortion patterns from two isolated obstacles. To that end we show, in Figs. 4(a) and 4(b), the current flow around two cylinders for $(J) \perp B$ and $(J) \parallel B$, where the distortion pattern around each cylinder was calculated neglecting the influence of the other. The orientation of the coordinate system in Fig. 4 corresponds to $\alpha = 90^\circ$ (a) and $\alpha = 0^\circ$ (b) in the experiment. Note, however, that the figures also represent $\rho_\perp$ (a) and $\rho_\parallel$ (b) for $\alpha = j\pi/2$ with $j = 0, 1, 2 \ldots$. In terms of the transformed representation these angles are all equivalent for a square lattice. Figures 4(c) and 4(d) show the two flow fields [corresponding to Figs. 4(a) and 4(b)] projected onto the symmetry plane (perpendicular to $B$) halfway between the cylinders. The total in-plane current is obtained by adding the two vector fields. Clearly, in Fig. 4(c) there is a perfect reinforcement while in Fig. 4(d) there is a perfect cancellation of the two distortion patterns. This corresponds, for $\alpha = j\pi/2$, to a maximum in $\rho_\perp$ and a minimum in $\rho_\parallel$ [15]. When $B$ is tilted away from the cylinder-axes plane, i.e., $\alpha$ is changed, the amplification and cancellation of the current distortions become less perfect, resulting in a reduced $\rho_\perp$ and enhanced $\rho_\parallel$.

For holes with smaller radii, the onset of anisotropy occurs at higher $B$. On the other hand, for a radius which is small compared to the period of the antidot lattice the interference of patterns from nearest neighbors along additional directions, e.g., the $45^\circ$ direction (see also top of Fig. 3) becomes possible. This is due to the fact that the geometrical shadow can now reach a neighboring void along the diagonal of the square lattice, if the diameter of the inclusions is not too large. We therefore expect to find an additional maximum for $\rho_\perp$ and a minimum for $\rho_\parallel$ along the $45^\circ$ directions [10]. These features are clearly evident in Figs. 3(a) and 3(b). A more detailed, quantitative discussion of the interactions between current distortions from different obstacles and the local dissipation rate can be found in Refs. [10,16].

Finally, we note that the current distortions are three dimensional. They exhibit a nonvanishing component along the cylinder axes [see Figs. 4(a) and 4(b)]. Decreasing the film thickness reduces this component, and hence the anisotropy as well as the magnitude of the magnetoresistance [11]. For a strictly two-dimensional system there would be no magnetoresistance.

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[6] Note that $\int_{V} dV J(r) \cdot \hat{p} \sim J(r) - \langle J(r) \rangle = \int_{V} dV J(r) \cdot E(r) - V\langle J(r) \rangle \cdot \hat{p} \cdot \hat{J} \equiv 0$ holds, if the local form of Ohm’s law, $E(r) = \hat{p} \cdot J(r)$ remains valid.
[14] In the notation of Refs. [10,11,16] our $\rho_\perp$ corresponds to $\hat{p}_\perp$ and vice versa.
[15] The energy dissipation is dominated by distortions in the plane perpendicular to $B$, see Ref. [16].